

**Notice of References Cited**Application/Control No.  
**09/839,173**Applicant(s)/Patent Under Reexam  
**Asao et al.**Examiner  
**Thanh Lam**Art Unit  
**2834**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> <small>Country Code-Number-Kind Code</small>	<b>Date</b> <small>MM-YYYY<sup>1</sup></small>	<b>Name</b>	<b>Classification<sup>2</sup></b>	
A	4,849,665	7/1989	Kitamura et al.	310	68d
B	5,785,433	7/1998	Takahashi et al.	384	539
C	5,424,600	6/1995	Ishikawa et al.	310	220
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**NON-PATENT DOCUMENTS**

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